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Application/Control No.

10514427

Examiner

Applicant(s)/Patent Under Reexamination CAI ET AL.

Art Unit

David K O'Dell 1625

ORIGINAL					INTERNATIONAL CLASSIFICATION																		
	CLASS			SUBCLASS				CLAIMED			CLAIMED NON-CLAIMED				CLAIMED NON-CLAIM				NON-CLAIMED				
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CROSS REFERENCE(S)						┝	_	_	_			-	-	\dashv	+			_					
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Final	Original	Final	Original	Final	Original	Final	Original	Final	Original	Final	Original	Final	Original	Final	Original
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/David K O'Dell/ Examiner.Art Unit 1625 (Assistant Examiner)	12/5/2008 (Date)	Total Claims Allowed: 22			
/JANET L ANDRES/ Supervisory Patent Examiner.Art Unit 1625	12/08/2008	O.G. Print Claim(s)	O.G. Print Figure		
(Primary Examiner)	(Date)	1	-		